Application No.	Applicant(s)	
10/044,686	SAKAI ET AL.	
Examiner	Art Unit	
Felisa C. Hiteshew	1765	

SEARCHED				
Class	Subclass	Date	Examiner	
117	84	10/9/2003	F.H.	
117	104	10/9/2003	F.H.	
117	937	10/9/2003	F.H.	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
1		-		
	!			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
STN (hcaplus, inspec, japio, uspatall) s (GaN or gallium(w)nitride) s (nitride)(8a)(crystal#) s(cut?(8a)substrate#)	10/9/2003	F.H.
s (front)(8a)(surface#) s (back?)(8a)(surface#) s (cut? or grind?)(8a)(substrate#) s (sapphire) s (electrode#)		
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